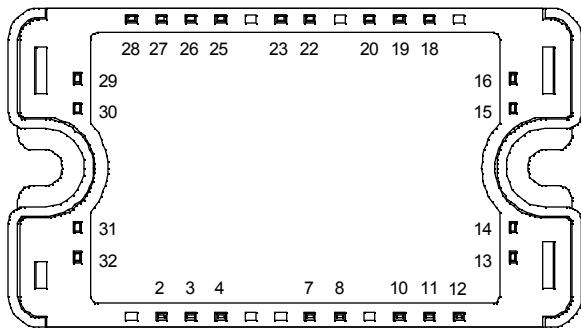
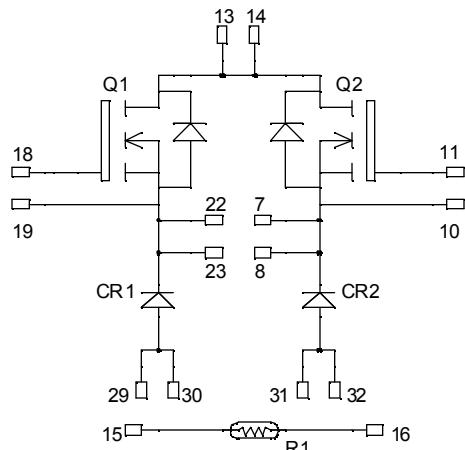


**Dual Buck chopper  
MOSFET Power Module**

**V<sub>DSS</sub> = 1200V**  
**R<sub>DSon</sub> = 570mΩ typ @ T<sub>j</sub> = 25°C**  
**I<sub>D</sub> = 17A @ T<sub>c</sub> = 25°C**



All multiple inputs and outputs must be shorted together  
 Example: 13/14 ; 29/30 ; 22/23 ...

**Absolute maximum ratings**

Symbol	Parameter	Max ratings	Unit
V <sub>DSS</sub>	Drain - Source Breakdown Voltage	1200	V
I <sub>D</sub>	Continuous Drain Current	T <sub>c</sub> = 25°C T <sub>c</sub> = 80°C	17 13
I <sub>DM</sub>	Pulsed Drain current		
V <sub>GS</sub>	Gate - Source Voltage	±30	V
R <sub>DSon</sub>	Drain - Source ON Resistance	684	mΩ
P <sub>D</sub>	Maximum Power Dissipation	T <sub>c</sub> = 25°C	390
I <sub>AR</sub>	Avalanche current (repetitive and non repetitive)		
E <sub>AR</sub>	Repetitive Avalanche Energy	50	mJ
E <sub>AS</sub>	Single Pulse Avalanche Energy	3000	

 **CAUTION:** These Devices are sensitive to Electrostatic Discharge. Proper Handing Procedures Should Be Followed. See application note APT0502 on [www.microsemi.com](http://www.microsemi.com)

All ratings @  $T_j = 25^\circ\text{C}$  unless otherwise specified

**Electrical Characteristics**

Symbol	Characteristic	Test Conditions		Min	Typ	Max	Unit
$I_{DSS}$	Zero Gate Voltage Drain Current	$V_{GS} = 0\text{V}$ , $V_{DS} = 1200\text{V}$	$T_j = 25^\circ\text{C}$			250	$\mu\text{A}$
		$V_{GS} = 0\text{V}$ , $V_{DS} = 1000\text{V}$	$T_j = 125^\circ\text{C}$			1000	
$R_{DS(on)}$	Drain – Source on Resistance	$V_{GS} = 10\text{V}$ , $I_D = 8.5\text{A}$			570	684	$\text{m}\Omega$
$V_{GS(th)}$	Gate Threshold Voltage	$V_{GS} = V_{DS}$ , $I_D = 2.5\text{mA}$		3		5	$\text{V}$
$I_{GSS}$	Gate – Source Leakage Current	$V_{GS} = \pm 30\text{ V}$ , $V_{DS} = 0\text{V}$				$\pm 100$	$\text{nA}$

**Dynamic Characteristics**

Symbol	Characteristic	Test Conditions		Min	Typ	Max	Unit
$C_{iss}$	Input Capacitance	$V_{GS} = 0\text{V}$ $V_{DS} = 25\text{V}$ $f = 1\text{MHz}$			5155		$\text{pF}$
$C_{oss}$	Output Capacitance				770		
$C_{rss}$	Reverse Transfer Capacitance				130		
$Q_g$	Total gate Charge	$V_{GS} = 10\text{V}$ $V_{Bus} = 600\text{V}$ $I_D = 17\text{A}$			187		$\text{nC}$
$Q_{gs}$	Gate – Source Charge				24		
$Q_{gd}$	Gate – Drain Charge				120		
$T_{d(on)}$	Turn-on Delay Time		<b>Inductive switching @ 125°C</b>		20		$\text{ns}$
$T_r$	Rise Time	$V_{GS} = 15\text{V}$			15		
$T_{d(off)}$	Turn-off Delay Time	$V_{Bus} = 800\text{V}$			160		
$T_f$	Fall Time	$I_D = 17\text{A}$			45		
$E_{on}$	Turn-on Switching Energy	<b>Inductive switching @ 25°C</b> $V_{GS} = 15\text{V}$ , $V_{Bus} = 800\text{V}$ $I_D = 17\text{A}$ , $R_G = 5\Omega$			990		$\mu\text{J}$
$E_{off}$	Turn-off Switching Energy				685		
$E_{on}$	Turn-on Switching Energy		<b>Inductive switching @ 125°C</b>		1565		$\mu\text{J}$
$E_{off}$	Turn-off Switching Energy	$V_{GS} = 15\text{V}$ , $V_{Bus} = 800\text{V}$			857		

**Reverse diode ratings and characteristics**

Symbol	Characteristic	Test Conditions		Min	Typ	Max	Unit	
$V_{RRM}$	Maximum Peak Repetitive Reverse Voltage			1200			$\text{V}$	
$I_{RM}$	Maximum Reverse Leakage Current	$V_R = 1200\text{V}$	$T_j = 25^\circ\text{C}$			250	$\mu\text{A}$	
			$T_j = 125^\circ\text{C}$			500		
$I_F$	DC Forward Current		$T_c = 80^\circ\text{C}$		25		$\text{A}$	
$V_F$	Diode Forward Voltage	$I_F = 25\text{A}$ $V_{GE} = 0\text{V}$	$T_j = 25^\circ\text{C}$		2.1		$\text{V}$	
			$T_j = 125^\circ\text{C}$		1.9			
$t_{rr}$	Reverse Recovery Time	$I_F = 25\text{A}$ $V_R = 600\text{V}$ $di/dt = 1000\text{A}/\mu\text{s}$	$T_j = 25^\circ\text{C}$		95		$\text{ns}$	
			$T_j = 125^\circ\text{C}$		190			
$Q_{rr}$	Reverse Recovery Charge		$T_j = 25^\circ\text{C}$		2.3		$\mu\text{C}$	
			$T_j = 125^\circ\text{C}$		4.5			

**Thermal and package characteristics**

Symbol    Characteristic

			Min	Typ	Max	Unit
R <sub>thJC</sub>	Junction to Case Thermal Resistance	Transistor			0.32	°C/W
		Diode			1.2	
V <sub>ISOL</sub>	RMS Isolation Voltage, any terminal to case t = 1 min, I <sub>isol</sub> < 1mA, 50/60Hz	2500				V
T <sub>J</sub>	Operating junction temperature range	-40		150		
T <sub>STG</sub>	Storage Temperature Range	-40		125		°C
T <sub>C</sub>	Operating Case Temperature	-40		100		
Torque	Mounting torque	To heatsink	M4	2.5	4.7	N.m
Wt	Package Weight				110	g

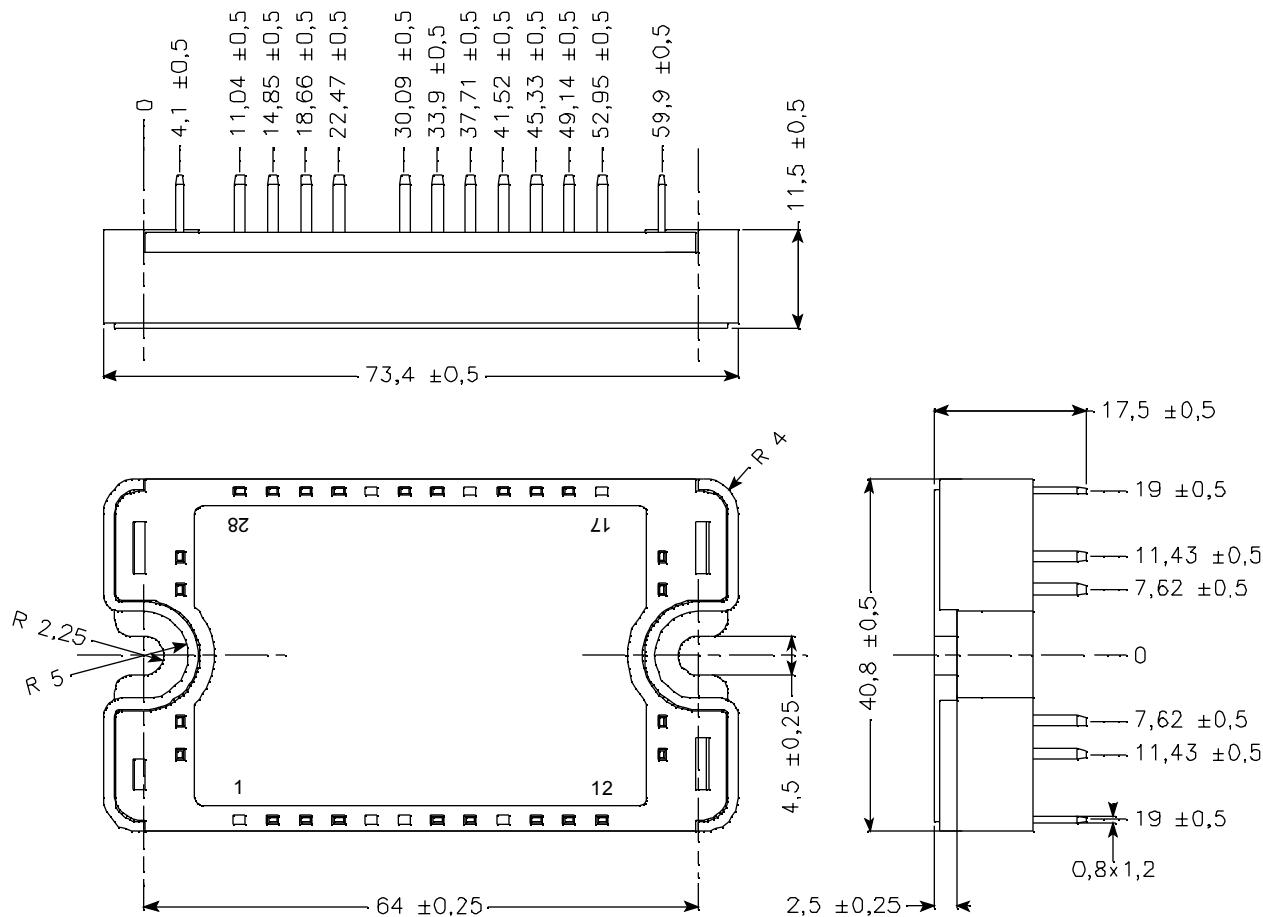
**Temperature sensor NTC** (see application note APT0406 on www.microsemi.com for more information).

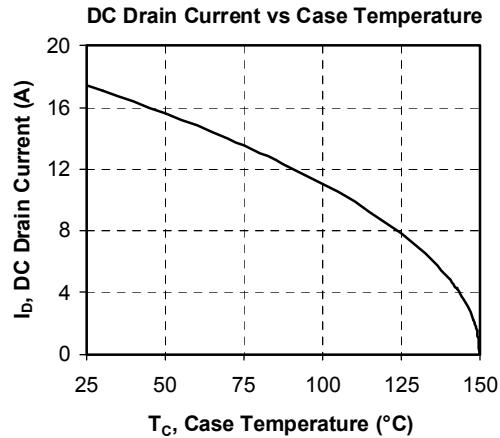
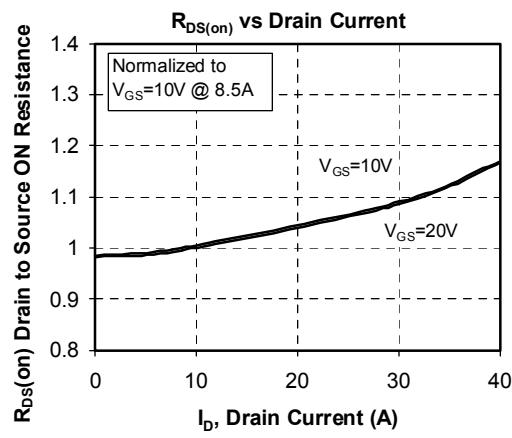
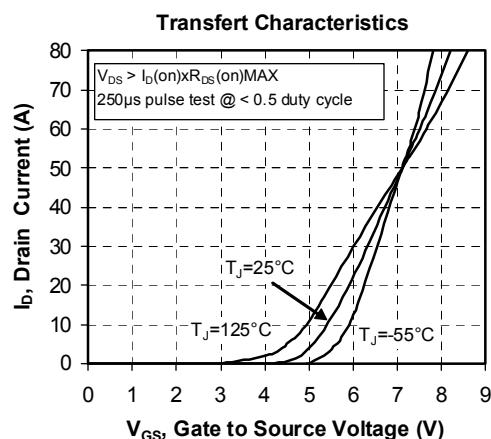
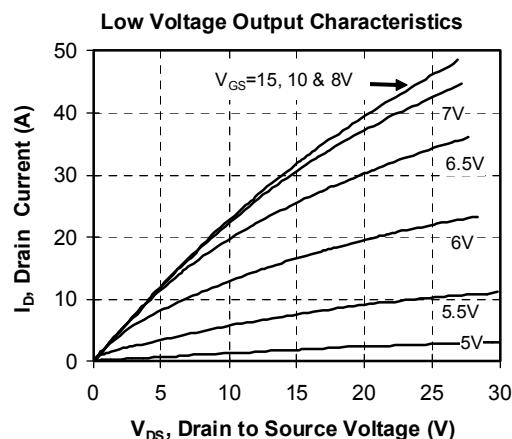
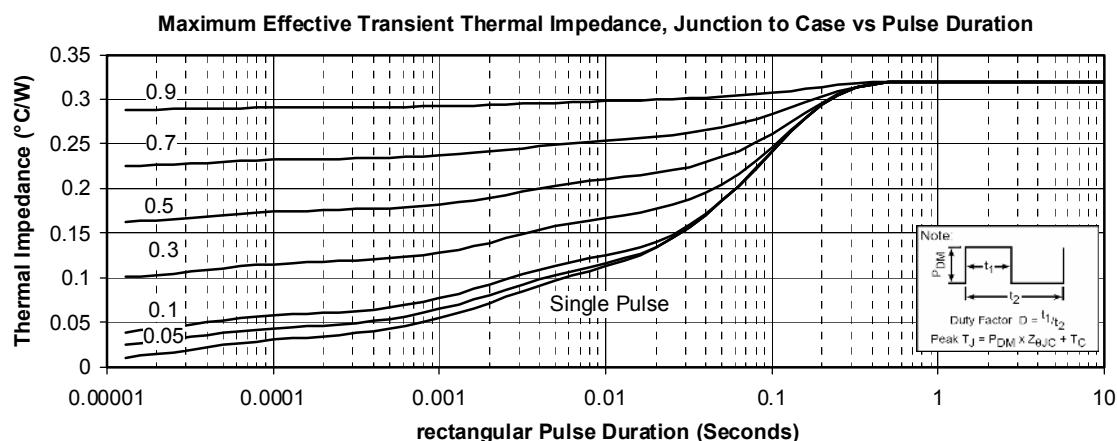
Symbol    Characteristic

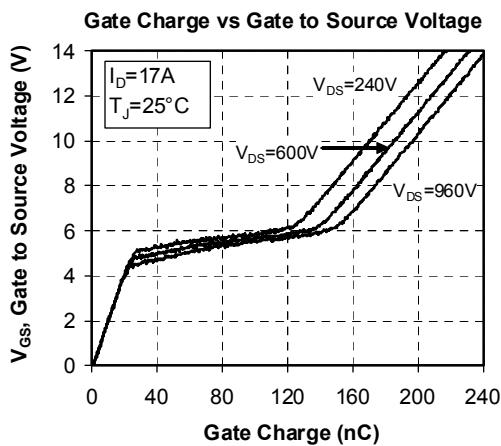
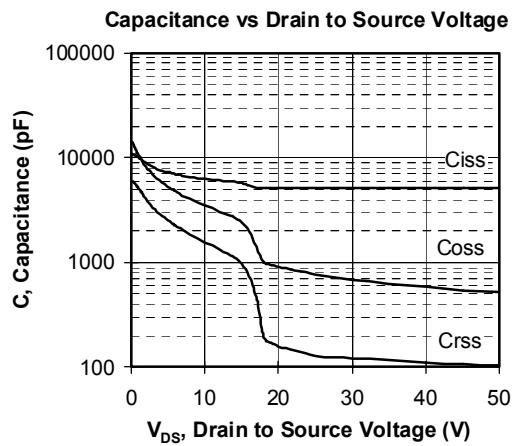
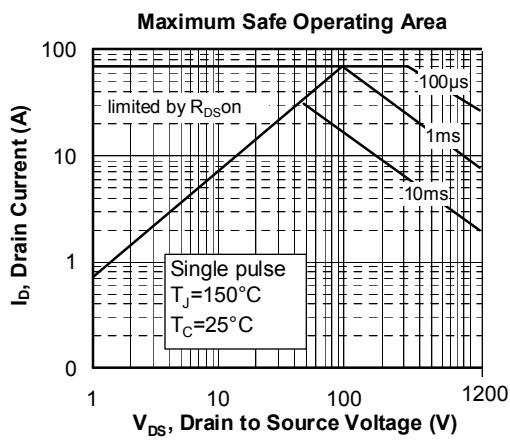
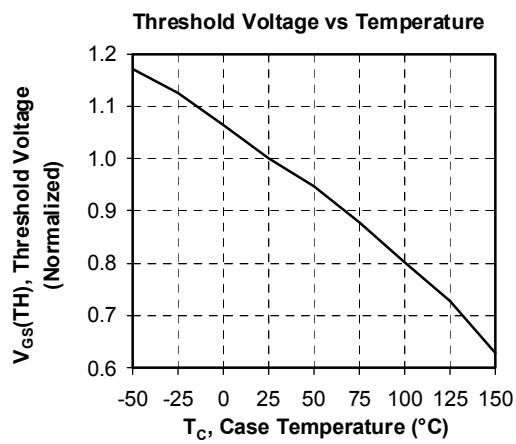
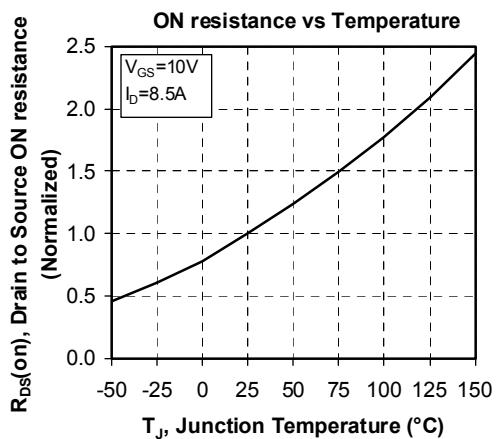
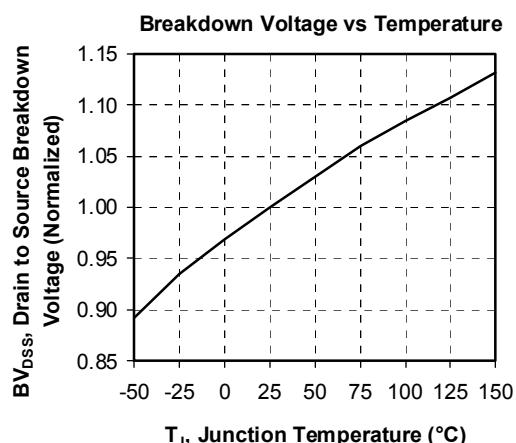
		Min	Typ	Max	Unit
R <sub>25</sub>	Resistance @ 25°C		50		kΩ
B <sub>25/85</sub>	T <sub>25</sub> = 298.15 K		3952		K

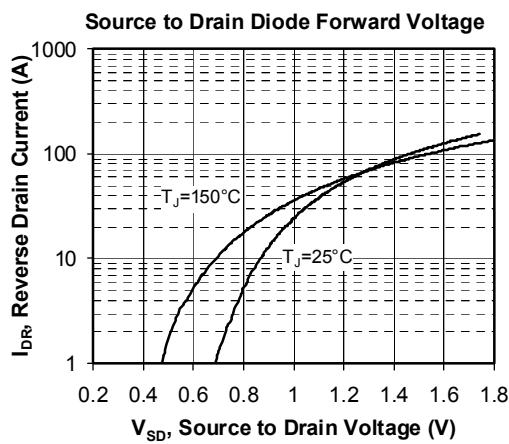
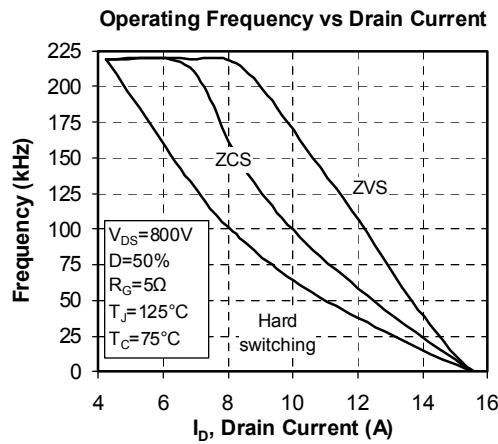
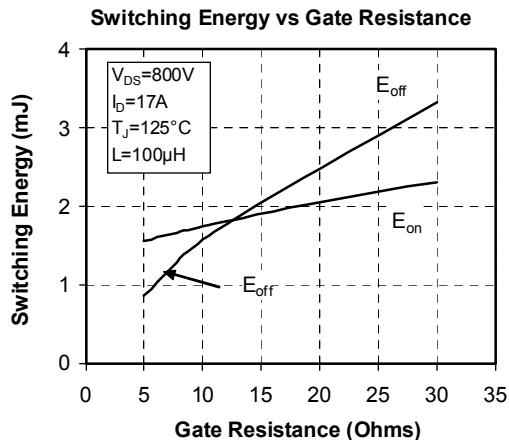
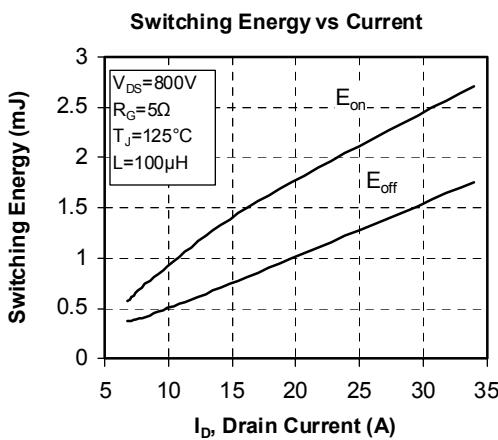
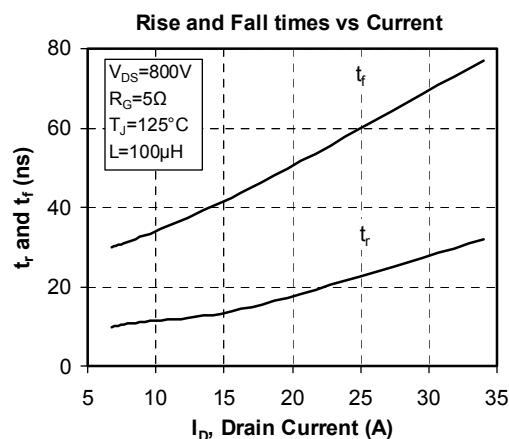
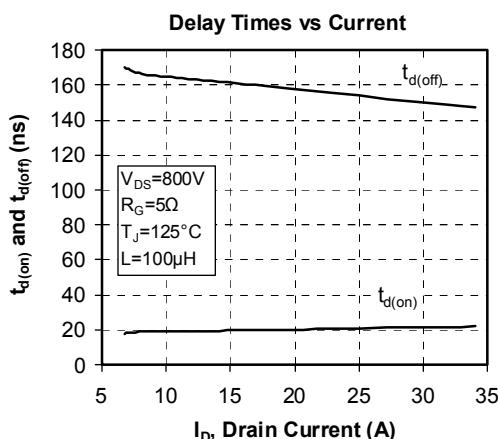
$$R_T = \frac{R_{25}}{\exp\left[B_{25/85}\left(\frac{1}{T_{25}} - \frac{1}{T}\right)\right]} \quad T: \text{Thermistor temperature}$$

R<sub>T</sub>: Thermistor value at T

**SP3 Package outline (dimensions in mm)**

 See application note 1901 - Mounting Instructions for SP3 Power Modules on [www.microsemi.com](http://www.microsemi.com)

**Typical Performance Curve**






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